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Application/Control No.	Applicant(s)/Patent under Reexamination
10/507,072	NAKANO, TATSUHIKO
Examiner	Art Unit
Tri V. Nguyen	1751

SEARCHED				
Class	Subclass	Date	Examiner	
8	536	3/3/2007	NVT	
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· INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (updated see attached)	3/3/2007	NVT